

ISO 22489:2006-12 (E)

Microbeam analysis - Electron probe microanalysis - Quantitative point analysis for bulk specimens using wavelength-dispersive X-ray spectroscopy

Contents		Page
1	Scope	1
2	Normative references	1
3	Abbreviated terms	2
4	Procedure for quantification	2
4.1	General procedure for quantitative microanalysis	2
4.2	Specimen preparation	3
4.3	Calibration of the instrument	3
4.4	Analysis conditions	4
4.5	Correction method based on analytical models	7
4.6	Calibration curve method	8
4.7	Uncertainty	8
5	Test report	8
Annex A (informative) Physical effects and correction		10
Annex B (informative) Outline of various correction techniques		11
Annex C (normative) Measurement of the ρ-ratios in the case of "chemical effects"		13
Bibliography		14